

DESCRIPTION

Title of Invention: METHOD FOR PRODUCING PERFLUOROALKADIENE
COMPOUNDS

5 Technical Field
 [0001]

 The present invention relates to a method for producing
a perfluoroalkadiene compound.

10 Background Art
 [0002]

 Perfluoroalkadiene compounds are useful as dry etching
gases for semiconductors, as well as useful as refrigerants,
foaming agents, heat transfer media, etc.; and have two double
15 bonds between carbon atoms. In particular, hexafluorobutadiene
having four carbon atoms, and a double bond at both terminals, is
used for various purposes.
 [0003]

 As a method for producing a perfluoroalkadiene compound,
20 a method for carrying out deiodo fluorination of α, ω -diiodo
pentafluoroalkane by a reaction of an organic metal compound such
as Mg, Zn, Cd, or Li at a desired temperature in the presence of
a polar aprotic solvent that belongs to ethers and cyclic ethers
(see, for example, Patent Literature 1) is known. Additionally,
25 performing deiodo fluorination of a compound such as $\text{ICF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{I}$
in the presence of metal zinc and a nitrogen-containing compound
is also known as a method for producing a perfluoroalkadiene
compound.

30 Citation List
 Patent Literature
 [0004]

 PTL 1: JP1987-26240A

35 Summary of Invention

Technical Problem

[0005]

However, the organic metal reagents (n-butyl lithium, ethylmagnesium bromide, etc.) used in the method of PTL 1 are expensive, are difficult to handle due to their high reactivity, and cannot provide sufficient yield. Further, even in the method for performing deiodofluorination of a compound such as $\text{ICF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{I}$ in the presence of metal zinc and a nitrogen-containing compound, the yield is still insufficient.

[0006]

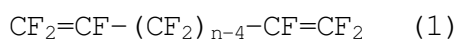
The present invention solves the above problems, and aims to provide a method for obtaining a perfluoroalkadiene compound at a high yield.

Solution to Problem

[0007]

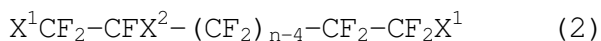
The present inventors conducted extensive research to solve the above problems. As a result, they found that a perfluoroalkadiene compound can be obtained at a high yield by adding a nitrogen-containing compound and optionally zinc to a solution of a specific compound. The inventors conducted further research based on this finding, and accomplished the present invention. Specifically, the present invention includes the following subject matter.

Item 1. A method for producing a perfluoroalkadiene compound represented by general formula (1):



wherein n is an integer of 4 or more,

the method comprising a reaction step of adding a nitrogen-containing compound to a solution of a compound represented by general formula (2):



wherein n is the same as above, X^1 is the same or different and is a halogen atom other than fluorine, and X^2 is a halogen atom.

Item 2. The production method according to Item 1, wherein the nitrogen-containing compound has an addition rate of 0.001 to 60 mol/h per mol of the compound represented by general formula (2).

5

Item 3. The production method according to Item 1 or 2, wherein the nitrogen-containing compound is N,N-dimethylformamide.

Item 4. The production method according to any one of Items 1 to 3, wherein the solution is a solution of an organic solvent.

10

Item 5. The production method according to Item 4, wherein the boiling point of the organic solvent is lower than the boiling point of the nitrogen-containing compound.

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Item 6. The production method according to any one of Items 1 to 5, wherein in the reaction step, the solution of the compound represented by general formula (2) further comprises zinc or a zinc alloy.

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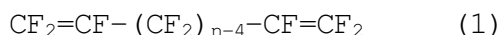
Item 7. The production method according to any one of Items 1 to 6, wherein the nitrogen-containing compound is added after the solution of the compound represented by general formula (2) is heated.

25

Item 8. The production method according to Item 7, wherein the heating is performed at reflux temperature.

Item 9. A perfluoroalkadiene composition comprising:

30 a perfluoroalkadiene compound represented by general formula (1):



wherein n is an integer of 4 or more, and

at least one additional compound selected from fluorocarbon

compounds (excluding the perfluoroalkadiene compound represented

35 by general formula (1)) having one or more double bonds.

Item 10. The perfluoroalkadiene composition according to Item 9,
wherein the amount of the additional compound is 0.1 to 45 mol%
when the total amount of the perfluoroalkadiene composition is
5 100 mol%.

Item 11. The perfluoroalkadiene composition according to Item 9
or 10, wherein the additional compound is at least one member
selected from the group consisting of fluorine-containing alkene
10 compounds having 4 or more carbon atoms and fluorine-containing
alkane compounds having 4 or more carbon atoms.

Item 12. The perfluoroalkadiene composition according to any one
of Items 9 to 11, wherein the perfluoroalkadiene compound is
15 hexafluorobutadiene.

Item 13. The perfluoroalkadiene composition according to any one
of Items 9 to 12, wherein the additional compound is at least one
member selected from the group consisting of octafluoro-1-butene,
20 octafluoro-2-butene, heptafluoro-1-butene, and heptafluoro-2-
butene.

Item 14. An etching gas, a refrigerant, a heat transfer medium, a
foaming agent, or a resin monomer, each comprising the
25 perfluoroalkadiene composition according to any one of Items 9 to
13.

Advantageous Effects of Invention

[0008]

30 According to the present invention, a
perfluoroalkadiene compound can be produced at a high yield.

Description of Embodiments

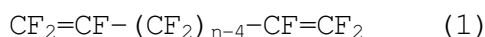
[0009]

35 In the present invention, the term "comprise/contain"

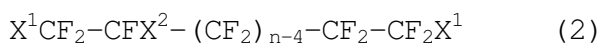
encompasses the concepts of "comprise," "consist essentially of," and "consist of."

[0010]

5 The perfluoroalkadiene compound production method of the present invention is a method for producing a perfluoroalkadiene compound represented by general formula (1):



wherein n is an integer of 4 or more, and the method comprises a reaction step of adding a nitrogen-containing compound to a solution of a compound represented by general formula (2):



wherein n is the same as above, X^1 is the same or different and is a halogen atom other than fluorine, and X^2 is a halogen atom.

[0011]

15 In general formulae (1) and (2), n is an integer of 4 or more, preferably 4 to 20, and more preferably 4 to 10. When n is in this range, the perfluoroalkadiene compound can be obtained at a higher yield.

[0012]

20 Specifically, examples of the perfluoroalkadiene compound of general formula (1) to be produced include $\text{CF}_2=\text{CF}-\text{CF}=\text{CF}_2$, $\text{CF}_2=\text{CF}-\text{CF}_2-\text{CF}=\text{CF}_2$, $\text{CF}_2=\text{CF}-\text{CF}_2-\text{CF}_2-\text{CF}=\text{CF}_2$, etc.

[0013]

25 In general formula (2), X^1 is a halogen atom other than fluorine, and examples include chlorine, bromine, iodine, etc. Of these, chlorine or iodine is preferred because the perfluoroalkadiene compound can be obtained at a higher yield. Each X^1 may be the same or different.

[0014]

30 In general formula (2), X^2 is a halogen atom, and examples include fluorine, chlorine, bromine, iodine, etc. Of these, fluorine or chlorine is preferred, and chlorine is more preferred because the perfluoroalkadiene compound can be obtained at a higher yield.

35 [0015]

Examples of the compound of general formula (2) that satisfy the above conditions include $\text{ClCF}_2\text{-CFCl-CF}_2\text{-CF}_2\text{I}$, $\text{ClCF}_2\text{-CFCl-CF}_2\text{-CF}_2\text{-CF}_2\text{I}$, $\text{ClCF}_2\text{-CFCl-CF}_2\text{-CF}_2\text{-CF}_2\text{-CF}_2\text{I}$, $\text{ICF}_2\text{-CF}_2\text{-CF}_2\text{-CF}_2\text{I}$, $\text{ICF}_2\text{-CF}_2\text{-CF}_2\text{-CF}_2\text{-CF}_2\text{I}$, $\text{ICF}_2\text{-CF}_2\text{-CF}_2\text{-CF}_2\text{-CF}_2\text{-CF}_2\text{I}$, etc. Because the perfluoroalkadiene compound can be obtained at a higher yield,
5 $\text{ClCF}_2\text{-CFCl-CF}_2\text{-CF}_2\text{I}$, $\text{ClCF}_2\text{-CFCl-CF}_2\text{-CF}_2\text{-CF}_2\text{I}$, and $\text{ClCF}_2\text{-CFCl-CF}_2\text{-CF}_2\text{-CF}_2\text{-CF}_2\text{I}$ are preferred, and $\text{ClCF}_2\text{-CFCl-CF}_2\text{-CF}_2\text{I}$ is more preferred.
[0016]

In the production method of the present invention, a
10 solution of the compound represented by general formula (2) is first prepared. As an organic solvent used in the solution, a nonpolar organic solvent is preferred. Such an organic solvent preferably has a boiling point lower than that of a nitrogen-containing compound, because the nitrogen-containing compound is
15 added after the solution of the compound represented by general formula (2) is heated. Examples of organic solvents include heptane, hexane, benzene, toluene, xylene, etc.
[0017]

The amount of the organic solvent to be used is not
20 limited, as long as it is a solvent amount; and is preferably 3 to 55 mol, and more preferably 4 to 8.5 mol, per mol of the compound represented by general formula (2).
[0018]

The nitrogen-containing compound is not limited, as
25 long as it is a compound containing nitrogen. Examples include amide compounds (such as N,N-dimethylformamide and N,N-diisopropylformamide), amine compounds (such as triethylamine), pyridine compounds (such as pyridine, methylpyridine, and N-methyl-2-pyrrolidone), quinoline compounds (such as quinoline and
30 methylquinoline), etc. Such nitrogen-containing compounds can be used alone, or in a combination of two or more. Of these, amide compounds are preferred, and N,N-dimethylformamide is more preferred, because the perfluoroalkadiene compound can be obtained at a higher yield.
35 [0019]

The nitrogen-containing compound may be a liquid at room temperature; however, the nitrogen-containing compound is preferably used (in a small amount) as an additive rather than a solvent, because the perfluoroalkadiene compound can be obtained at a higher yield. The amount of the nitrogen-containing compound to be used is preferably 0.25 to 2 mol, and more preferably 0.5 to 1 mol, per mol of the compound represented by general formula (2).

[0020]

The nitrogen-containing compound is preferably added after the solution of the compound represented by general formula (2) is heated (hereinbelow, sometimes referred to as "added afterwards"). The heating conditions are not limited; 50 to 200°C is preferred, and 100 to 150°C is more preferred. In particular, heating at reflux temperature is most preferred.

[0021]

When the nitrogen-containing compound is added after heating (in particular, heating at reflux temperature), the addition rate (dropwise addition rate) of the nitrogen-containing compound is preferably 0.001 to 60 mol/h, and more preferably 0.01 to 10 mol/h, because the perfluoroalkadiene compound represented by general formula (1) can be obtained at a higher yield.

[0022]

In the present invention, the addition of zinc or a zinc alloy during the reaction is preferred. This allows the reaction to proceed more readily, and enables obtainment of the perfluoroalkadiene compound represented by general formula (1) at a higher yield. Zinc or a zinc alloy is preferably added before heating.

[0023]

When a zinc alloy is used, examples of elements that can be contained therein include lead, cadmium, iron, etc. Commercially available zinc sometimes contains impurities, such as lead, cadmium, and iron. The present invention includes those

containing such impurities.

[0024]

The amount of zinc or zinc alloy to be used is preferably 1 to 10 mol, and more preferably 2 to 5 mol, per mol
5 of the compound represented by general formula (2), because the perfluoroalkadiene compound represented by general formula (1) can be obtained at a higher yield.

[0025]

Reaction conditions other than the heating temperature
10 are not limited. For example, the reaction atmosphere is preferably an inert gas atmosphere (nitrogen gas atmosphere, argon gas atmosphere, etc.), and the reaction time is such that the reaction sufficiently proceeds. After the completion of the reaction, purification treatment is performed according to a
15 known method to obtain the perfluoroalkadiene compound represented by general formula (1).

[0026]

The perfluoroalkadiene compound represented by general formula (1) can thus be obtained; however, the perfluoroalkadiene
20 compound can also be obtained in the form of a perfluoroalkadiene composition comprising the perfluoroalkadiene compound represented by general formula (1), and at least one additional compound selected from fluorocarbon compounds (excluding the perfluoroalkadiene compound represented by general formula (1))
25 having one or more double bonds. Examples of the fluorocarbon compounds include fluorocarbon compounds having one or more double bonds, and 4 or more carbon atoms. Specific examples include one or two or more compounds selected from fluorine-containing alkene compounds having 4 or more carbon atoms, and
30 fluorine-containing alkane compounds having 4 or more carbon atoms. To obtain a perfluoroalkadiene compound (hexafluorobutadiene) represented by general formula (1) wherein n is 4, the fluorine-containing alkene compound can sometimes be obtained in the form of a composition (perfluoroalkadiene
35 composition) containing hexafluorobutadiene and at least one

fluorine-containing alkene compound selected from octafluoro-1-butene (e.g., $\text{CF}_2=\text{CFCF}_2\text{CF}_3$), octafluoro-2-butene (e.g., $\text{CF}_3\text{CF}=\text{CFCF}_3$), heptafluoro-1-butene (e.g., $\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$, $\text{CF}_2=\text{CFCFHCF}_3$), and heptafluoro-2-butene (e.g., $\text{CF}_3\text{CF}=\text{CHCF}_3$).

5 [0027]

When a fluorine-containing alkane compound having 4 or more carbon atoms is contained in the perfluoroalkadiene composition of the present invention that is formed for when the perfluoroalkadiene compound represented by general formula (1) is
10 obtained, $\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$, $\text{HCF}_2\text{CFHCF}_2\text{CF}_3$, $\text{CF}_3\text{CFHCFHCF}_3$, etc., can be used as the fluorine-containing alkane compound. Such additional compounds can be efficiently used for various purposes, including etching gases for forming state-of-the-art microstructures such as semiconductors and liquid crystals; refrigerants; heat
15 transfer media; foaming agents; resin monomers; etc., in the same manner as hexafluorobutadiene.

[0028]

In the perfluoroalkadiene composition of the present invention, the amount of the perfluoroalkadiene compound
20 represented by general formula (1) is preferably 55 to 99.9 mol% (particularly 73 to 99.9 mol%), and the amount of the additional compound is preferably 0.1 to 45 mol% (particularly 0.1 to 27 mol%), when the total amount of the perfluoroalkadiene composition of the present invention is 100 mol%.

25 [0029]

As in the case of the single use of the perfluoroalkadiene compound as described above, the perfluoroalkadiene composition of the present invention can be efficiently used for various purposes, including etching gases
30 for forming state-of-the-art microstructures such as semiconductors and liquid crystals; refrigerants; heat transfer media; foaming agents; resin monomers; etc.

Examples

35 [0030]

The features of the present invention are clarified with reference to the Examples shown below. The present invention is not limited to these Examples.

[0031]

5 Example 1

An Eggplant flask equipped with a condenser, to which a trap is connected, was cooled to -78°C , and 40 g (0.16 mol) of xylene, 7.25 g (0.12 mol) of zinc, and 20 g (0.05 mol) of a starting material ($\text{ClCF}_2\text{CFClCF}_2\text{CF}_2\text{I}$) were added to the eggplant
10 flask. Heating was then conducted under stirring until the inside temperature became 140°C . After the inside temperature became constant, N,N-dimethylformamide (DMF) was added dropwise under reflux at a dropwise addition rate of 0.04 mol/hour (0.8 mol/hour per mol of the starting material ($\text{ClCF}_2\text{CFClCF}_2\text{CF}_2\text{I}$)) for 1 hour,
15 and heating reflux was continued while stirring. After the completion of the reaction, a liquid collected in the trap was analyzed by gas chromatography. The results showed that $\text{CF}_2=\text{CFCF}=\text{CF}_2$ was 89 mol%, $\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$ was 3 mol%, $\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$ was 0 mol%, and other side products (octafluoro-1-butene,
20 octafluoro-2-butene, heptafluoro-1-butene other than $\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$, heptafluoro-2-butene, octafluorobutane other than $\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$) were 8 mol% in total. Specifically, the amount of the additional compounds was 11 mol%.

[0032]

25 Example 2

Treatment was performed in the same manner as in Example 1, except that $\text{ICF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{I}$ was used as a starting material (substrate) in place of $\text{ClCF}_2\text{CFClCF}_2\text{CF}_2\text{I}$. After the completion of the reaction, a liquid collected in the trap was
30 analyzed by gas chromatography. The results showed that $\text{CF}_2=\text{CFCF}=\text{CF}_2$ was 73 mol%, $\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$ was 20 mol%, $\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$ was 5 mol%, and other side products (octafluoro-1-butene, octafluoro-2-butene, heptafluoro-1-butene other than $\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$, heptafluoro-2-butene, octafluorobutane other than $\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$)
35 was 2 mol%. Specifically, the amount of the additional compounds

was 27 mol%.

[0033]

Reference Example 1

20 g (0.27 mol) of N,N-dimethylformamide (DMF) and 9 g
5 (0.14 mol) of zinc were added to an eggplant flask equipped with
a condenser that was cooled to -78°C , and to which a trap was
connected. The flask was stirred and heated until the inside
temperature became 140°C . After the inside temperature became
constant, 20 g (0.04 mol) of a starting material ($\text{ICF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{I}$)
10 was added thereto, and heating reflux was continued while
stirring. After the completion of the reaction, a liquid
collected in the trap was analyzed by gas chromatography. The
results showed that $\text{CF}_2=\text{CFCF}=\text{CF}_2$ was 4 mol%, $\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$ was 11
mol%, $\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$ was 71 mol%, and other side products
15 (octafluoro-1-butene, octafluoro-2-butene, heptafluoro-1-butene
other than $\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$, heptafluoro-2-butene, octafluorobutane
other than $\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$) were 14 mol%. Specifically, the amount
of the additional compounds was 96 mol%.

[0034]

20 Reference Example 2

Treatment was performed in the same manner as in
Reference Example 1, except that $\text{ClCF}_2\text{CFClCF}_2\text{CF}_2\text{I}$ was used as a
starting material (substrate) in place of $\text{ICF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{I}$. After
the completion of the reaction, a liquid collected in the trap
25 was analyzed by gas chromatography. The results showed that
 $\text{CF}_2=\text{CFCF}=\text{CF}_2$ was 42 mol%, $\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$ was 47 mol%, $\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$
was 0 mol%, and other side products (octafluoro-1-butene,
octafluoro-2-butene, heptafluoro-1-butene other than $\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$,
heptafluoro-2-butene, octafluorobutane other than $\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$)
30 were 11 mol%. Specifically, the amount of the additional
compounds was 58 mol%.

[0035]

Reference Example 3

Treatment was performed in the same manner as in
35 Reference Example 1, except that the mixed solvent of 20 g (0.19

mol) of xylene and 2.36 g (0.03 mol) of DMF was used in place of 20 g (0.27 mol) of DMF solvent. After the completion of the reaction, a liquid collected in the trap was analyzed by gas chromatography. The results showed that $\text{CF}_2=\text{CFCF}=\text{CF}_2$ was 55 mol%,
 5 $\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$ was 22 mol%, $\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$ was 13 mol%, and other side products (octafluoro-1-butene, octafluoro-2-butene, heptafluoro-1-butene other than $\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$, heptafluoro-2-butene, octafluorobutane other than $\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$) were 10 mol%. Specifically, the amount of the additional compounds was 45 mol%.

10 [0036]

Reference Example 4

Treatment was performed in the same manner as in Reference Example 1, except that $\text{ClCF}_2\text{CFCF}_2\text{CF}_2\text{I}$ was used as a starting material (substrate) in place of $\text{ICF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{I}$, and the
 15 mixed solvent of 20 g (0.19 mol) of xylene and 2.36 g (0.03 mol) of DMF was used in place of 20 g (0.27 mol) of DMF solvent. After the completion of the reaction, a liquid collected in the trap was analyzed by gas chromatography. The results showed that $\text{CF}_2=\text{CFCF}=\text{CF}_2$ was 48 mol%, $\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$ was 39 mol%, $\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$
 20 was 0 mol%, and other side products (octafluoro-1-butene, octafluoro-2-butene, heptafluoro-1-butene other than $\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$, heptafluoro-2-butene, octafluorobutane other than $\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$) were 13 mol%. Specifically, the amount of the additional compounds was 52 mol%.

25 [0037]

Table 1 shows the results.

[0038]

Table 1

	Example		Reference Example			
	1	2	1	2	3	4
Substrate	$\text{ClCF}_2\text{CFCF}_2\text{CF}_2\text{I}$	$\text{ICF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{I}$	$\text{ICF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{I}$	$\text{ClCF}_2\text{CFCF}_2\text{CF}_2\text{C}$ F_2I	$\text{ICF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{I}$	$\text{ClCF}_2\text{CFCF}_2\text{CF}_2\text{C}$ F_2I
Solvent	Xylene	Xylene	DMF	DMF	DMF + Xylene	DMF + Xylene
Additive	DMF added afterwards	DMF added afterwards	—	—	—	—
Generated gas purity (%)						
$\text{CF}_2=\text{CF}=\text{CF}_2$	89	73	4	42	55	48
$\text{CF}_2=\text{CFCF}_2\text{CF}_2\text{H}$	3	20	11	47	22	39
$\text{HCF}_2\text{CF}_2\text{CF}_2\text{CF}_2\text{H}$	0	5	71	0	13	0
Others	8	2	14	11	10	13

Example 3

Under the etching conditions of 600 W of ICP (Inductive Coupled Plasma) discharge power, 200 W of bias power, 3 mTorr of pressure (0.399 Pa), 8×10^{10} to $2 \times 10^{11} \text{ cm}^{-3}$ of electron density, and 5 to 7 eV of electron temperature, a semiconductor substrate having an SiO_2 film with a thickness of about 1 μm on an Si substrate, and a resist pattern with a 0.21- μm -diameter hole formed thereon, was etched using cyclic C_4F_8 (conventional product) and C_4F_6 (structure: $\text{CF}_2=\text{CFCF}=\text{CF}_2$) containing the additional components produced in Example 1. Table 2 shows the etching rate and selectivity in the etching.

[0039]

Both the resist selectivity for electron beam lithography and the silicone selectivity of C_4F_6 (structure: $\text{CF}_2=\text{CFCF}=\text{CF}_2$) were higher than those of c- C_4F_8 .

[0040]

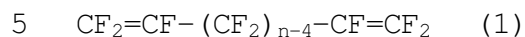
Table 2

Gas	SiO_2 etching rate	Resist etching rate	Resist selectivity	Si etching rate	Silicone selectivity
	$\text{\AA}/\text{min}$	$\text{\AA}/\text{min}$	$\text{SiO}_2/\text{Resist}$	$\text{\AA}/\text{min}$	SiO_2/Si
c- C_4F_8 (Conventional product)	6776	5061	1.34	2748	2.47
C_4F_6	5470	2442	2.24	870	6.29

CLAIMS

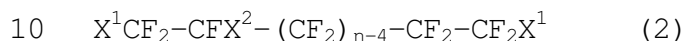
[Claim 1]

A method for producing a perfluoroalkadiene compound represented by general formula (1):



wherein n is an integer of 4 or more,

the method comprising a reaction step of adding a nitrogen-containing compound to a solution of a compound represented by general formula (2):



wherein n is the same as above, X^1 is the same or different and is a halogen atom other than fluorine, and X^2 is a halogen atom.

[Claim 2]

15 The production method according to claim 1, wherein the addition rate of the nitrogen-containing compound is 0.001 to 60 mol/h per mol of the compound represented by general formula (2).

[Claim 3]

20 The production method according to claim 1 or 2, wherein the nitrogen-containing compound is N,N-dimethylformamide.

[Claim 4]

25 The production method according to any one of claims 1 to 3, wherein the solution is a solution of an organic solvent.

[Claim 5]

30 The production method according to claim 4, wherein the boiling point of the organic solvent is lower than the boiling point of the nitrogen-containing compound.

[Claim 6]

35 The production method according to any one of claims 1 to 5, wherein in the reaction step, the solution of the compound represented by general formula (2) further comprises zinc or a

zinc alloy.

[Claim 7]

The production method according to any one of claims 1
5 to 6, wherein the nitrogen-containing compound is added after the
solution of the compound represented by general formula (2) is
heated.

[Claim 8]

10 The production method according to claim 7, wherein the
heating is performed at reflux temperature.

[Claim 9]

A perfluoroalkadiene composition comprising:
15 a perfluoroalkadiene compound represented by general formula (1):
$$\text{CF}_2=\text{CF}-(\text{CF}_2)_{n-4}-\text{CF}=\text{CF}_2 \quad (1)$$

wherein n is an integer of 4 or more, and
at least one additional compound selected from fluorocarbon
compounds (excluding the perfluoroalkadiene compound represented
20 by general formula (1)) having one or more double bonds.

[Claim 10]

The perfluoroalkadiene composition according to claim 9,
wherein the amount of the additional compound is 0.1 to 45 mol%
25 when the total amount of the perfluoroalkadiene composition is
100 mol%.

[Claim 11]

The perfluoroalkadiene composition according to claim 9
30 or 10, wherein the additional compound is at least one member
selected from the group consisting of fluorine-containing alkene
compounds having 4 or more carbon atoms and fluorine-containing
alkane compounds having 4 or more carbon atoms.

35 [Claim 12]

The perfluoroalkadiene composition according to any one of claims 9 to 11, wherein the perfluoroalkadiene compound is hexafluorobutadiene.

5 [Claim 13]

The perfluoroalkadiene composition according to any one of claims 9 to 12, wherein the additional compound is at least one member selected from the group consisting of octafluoro-1-butene, octafluoro-2-butene, heptafluoro-1-butene, and
10 heptafluoro-2-butene.

[Claim 14]

An etching gas, a refrigerant, a heat transfer medium, a foaming agent, or a resin monomer, each comprising the
15 perfluoroalkadiene composition according to any one of claims 9 to 13.